	Application No.	Applicant(s)	_
Notice of Allowability	09/704,864	FOTH ET AL.	
	Examiner	Art Unit	_
	Pierre E. Elisca	3621	
The MAILING DATE of this communication appeal All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIOF the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this a or other appropriate communication IGHTS. This application is subject	pplication. If not included on will be mailed in due course. THIS	е
1. This communication is responsive to <u>7/22/2005</u> .			
2. X The allowed claim(s) is/are 1-18.			
 Acknowledgment is made of a claim for foreign priority ur All b)	e been received. e been received in Application No. cuments have been received in this of this communication to file a repl IENT of this application. itted. Note the attached EXAMINE es reason(s) why the oath or declar at be submitted. con's Patent Drawing Review (PTC	y complying with the requirements R'S AMENDMENT or NOTICE OF ration is deficient.	
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in the	.84(c)) should be written on the draw he header according to 37 CFR 1.121	rings in the front (not the back) of (d).	
 DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT 	sit of BIOLOGICAL MATERIAL FOR THE DEPOSIT OF BIOLOGIO	must be submitted. Note the CAL MATERIAL.	
Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview Summar Paper No./Mail Da 8), 7. ☐ Examiner's Amend	ate	
LLS Release and Trademody Office	Shalo PRIMARY	- June ? Examiner	

U.S. Patent and Trademark Office PTOL-37 (Rev. 7-05)

Notice of Allowability

Part of Paper No./Mail Date 20060108

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REASONS FOR ALLOWANCE

1. This is an Examiner's statement of reasons for allowance. The closest prior art Stefik U.S. Pat. No. 5,638,443 discloses a system/method for controlling use and distribution of composite digital works.

JP02004080751 A Bourne, Steven et al discloses a secure hardware identifier (HWID) for use in connection with a digital copyright management system.

However, neither Stefik nor Bourne singularly or in combination discloses the recited feature:

As per claim 1 " determining whether or not there is an existing copy of the protected material, storing an existing copy of the protected material from a plurality of sources of the protected material automatically for archival purposes at a site remote from the consumer at the time the material was first obtained by the consumer, and creating a pointer for the consumer to point to the stored archival material".

Conclusion

2. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Pierre E. Elisca whose telephone number is 571 272 6706. The examiner can normally be reached on 4:30AM to 2:00PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, James Trammell can be reached on 571 272 6712. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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Pierre Eddy Elisca

Primary Patent Examiner

January 08, 2006